Application/Control No. O9/885,217 Applicant(s)/Patent Under Reexamination KEETH ET AL. Examiner Quan Tra Applicant(s)/Patent Under Reexamination KEETH ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

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	Α	US-5,554,953 A	09-1996	Shibayama et al.	327/541			
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